

Notice of References Cited	Application/Control No. 10/604,546		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner TAN X. DINH		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,700,859 B2	03-2004	Oono et al.	369/223
*	D	US-6,445,649 B1	09-2002	Saito et al.	369/30.1
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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